Application/Control No. Applicant(s)/Patent Under Reexamination 10/628,253 KIM ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Satya B. Sastri 1713 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 11-1983 428/402 US-4,414,278 Cohen et al. Α US-В US-С US-D US-Ε US-F US-G US-Н US-1 US-. US-Κ US-US-M FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY JP 01004605 A 01-1989 TAKANO et al. Japan Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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